

# **Notice of References Cited**

Application/Control No.

10/524,737

Applicant(s)/Patent Under  
Reexamination  
HEYDECKE ET AL.

Examiner

Arun S. Phasge

Art Unit

1795

Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,379,517	04-2002	Heydecke et al.	204/522
*	B	US-6,294,066	09-2001	Mani, K. N.	204/523
*	C	US-5,874,204	02-1999	Sugawara et al.	430/399
TS 10/26/99	*	D	US-3,764,503	10-1973	Lancy et al.
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.